AT29C257

Features

- Fast Read Access Time 70 ns
- 5-Volt-Only Reprogramming
- Page Program Operation Single Cycle Reprogram (Erase and Program) Internal Address and Data Latches for 64-Bytes
- Internal Program Control and Timer
- Hardware and Software Data Protection
- Fast Program Cycle Times Page (64-Byte) Program Time - 10 ms Chip Erase Time - 10 ms
- DATA Polling for End of Program Detection
- Low Power Dissipation
 50 mA Active Current
 300 μA CMOS Standby Current
- Typical Endurance > 10,000 Cycles
- Single 5V ± 10% Supply
- CMOS and TTL Compatible Inputs and Outputs
- Pin-Compatible with AT29C010A and AT29C512 for Easy System Upgrades

Description

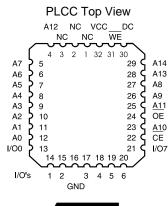
The AT29C257 is a 5-volt-only in-system Flash programmable and erasable read only memory (PEROM). Its 256K of memory is organized as 32,768 words by 8 bits. Manufactured with Atmel's advanced nonvolatile CMOS technology, the device offers access times to 70 ns with power dissipation of just 275 mW. When the device is deselected, the CMOS standby current is less than 300 μ A. The device endurance is such that any sector can typically be written to in excess of 10,000 times.

To allow for simple in-system reprogrammability, the AT29C257 does not require high input voltages for programming. Five-volt-only commands determine the operation of the device. Reading data out of the device is similar to reading from a static RAM. Reprogramming the AT29C257 is performed on a page basis; 64-bytes of data are loaded into the device and then simultaneously programmed. The contents of the entire device may be erased by using a 6-byte software code (although erasure before programming is not needed).

During a reprogram cycle, the address locations and 64-bytes of data are internally latched, freeing the address and data bus for other operations. Following the initiation of a program cycle, the device will automatically erase the page and then program the latched data using an internal control timer. The end of a program cycle can be detected by DATA polling of I/O7. Once the end of a program cycle has been detected a new access for a read, program or chip erase can begin.

Pin Configurations

Pin Name	Function
A0 - A14	Addresses
CE	Chip Enable
OE	Output Enable
WE	Write Enable
I/O0 - I/O7	Data Inputs/Outputs
NC	No Connect
DC	Don't Connect

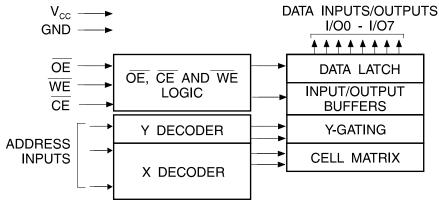




256K (32K x 8) 5-volt Only CMOS Flash Memory



Block Diagram



Device Operation

READ: The <u>AT29C257</u> is accessed like a static RAM. When CE and OE are low and WE is high, the data stored at the memory location determined by the address pins is asserted on the outputs. The outputs are put in the high impedance state whenever CE or OE is high. This dualline control gives designers flexibility in preventing bus contention.

BYTE LOAD: A byte load is performed by applying a low pulse on the WE or CE input with CE or WE low (respectively) and OE high. The address is latched on the falling edge of CE or WE, whichever occurs last. The data is latched by the first rising edge of CE or WE. Byte loads are used to enter the 64-bytes of a page to be programmed or the software codes for data protection and chip erasure.

PROGRAM: The device is reprogrammed on a page basis. If a byte of data within a page is to be changed, data for the entire page must be loaded into the device. Any byte that is not loaded during the programming of its page will be indeterminate. Once the bytes of a page are loaded into the device, they are simultaneously programmed during the internal programming period. After the first data byte has been loaded into the device, successive bytes are entered in the same manner. Each new byte to be programmed must have its high to low transition on \overline{WE} (or \overline{CE}) within 150 µs of the low to high transition of \overline{WE} (or CE) of the preceding byte. If a high to low transition is not detected within 150 µs of the last low to high transition, the load period will end and the internal programming period will start. A6 to A14 specify the page address. The page address must be valid during each high to low transition of WE (or CE). A0 to A5 specify the byte address within the page. The bytes may be loaded in any order; sequential loading is not required. Once a programming operation has been initiated, and for the duration of twc, a read operation will effectively be a polling operation.

SOFTWARE DATA PROTECTION: A software controlled data protection feature is available on the AT29C257. Once the software protection is enabled a software algorithm must be issued to the device before a program may be performed. The software protection feature may be enabled or disabled by the user; when shipped from Atmel, the software data protection feature is disabled. To enable the software data protection, a series of three program commands to specific addresses with specific data must be performed. After the software data protection is enabled the same three program commands must begin each program cycle in order for the programs to occur. All software program commands must obey the page program timing specifications. Once set, the software data protection feature remains active unless its disable command is issued. Power transitions will not reset the software data protection feature, however the software feature will guard against inadvertent program cycles during power transitions.

Once set, software data protection will remain active unless the disable command sequence is issued.

After setting SDP, any attempt to write to the device without the 3-byte command sequence will start the internal write timers. No data will be written to the device; however, for the duration of t_{WC} , a read operation will effectively be a polling operation.

After the software data protection's 3-byte command code is given, a byte load is performed by applying a low pulse on the WE or CE input with CE or WE low (respectively) and OE high. The address is latched on the falling edge of CE or WE, whichever occurs last. The data is latched by the first rising edge of CE or WE. The 64-bytes of data must be loaded into each sector by the same procedure as outlined in the program section under device operation.

(continued)

Device Operation (Continued)

HARDWARE DATA PROTECTION: Hardware features protect against inadvertent programs to the AT29C257 in the following ways: (a) V_{CC} sense— if V_{CC} is below 3.8V (typical), the program function is inhibited. (b) V_{CC} power on delay— once V_{CC} has reached the V_{CC} sense level, the device will automatically time out 5 ms (typical) before programming. (c) Program inhibit— holding any one of OE low, CE high or WE high inhibits program cycles. (d) Noise filter— pulses of less than 15 ns (typical) on the WE or CE inputs will not initiate a program cycle.

PRODUCT IDENTIFICATION: The product identification mode identifies the device and manufacturer and may be accessed by a hardware or software operation. For details, see Operating Modes or Software Product Identification. **DATA POLLING:** The AT29C257 features DATA polling to indicate the end of a program cycle. During a program cycle an attempted read of the last byte loaded will result in the complement of the loaded data on I/O7. Once the program cycle has been completed, true data is valid on all outputs and the next cycle may begin. DATA polling may begin at any time during the program cycle.

TOGGLE BIT: In addition to DATA polling the AT29C257 provides another method for determining the end of a program or erase cycle. During a program or erase operation, successive attempts to read data from the device will result in I/O6 toggling between one and zero. Once the program cycle has completed, I/O6 will stop toggling and valid data will be read. Examining the toggle bit may begin at any time during a program cycle.

OPTIONAL CHIP ERASE MODE: The entire device can be erased by using a 6-byte software code. Please see Software Chip Erase application note for details.

Absolute Maximum Ratings*

Temperature Under Bias55°C to +125°C
Storage Temperature65°C to +150°C
All Input Voltages (including NC Pins) with Respect to Ground0.6V to +6.25V
All Output Voltages with Respect to Ground0.6V to V _{CC} + 0.6V
Voltage on $\overline{\text{OE}}$ with Respect to Ground0.6V to +13.5V

^{*}NOTICE: Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.





DC and AC Operating Range

		AT29C257-70	AT29C257-90	AT29C257-12	AT29C257-15
Operating	Com.	0°C - 70°C	0°C - 70°C	0°C - 70°C	0°C - 70°C
Temperature (Case)	Ind.	-40°C - 85°C	-40°C - 85°C	-40°C - 85°C	-40°C - 85°C
V _{CC} Power Supply		5V ± 5%	5V ± 10%	5V ± 10%	5V ± 10%

Operating Modes

Mode	CE	OE	WE	Ai	I/O
Read	VIL	VIL	Vih	Ai	Dout
Program ⁽²⁾	VIL	Vін	VIL	Ai	DIN
5V Chip Erase	VIL	Vін	VIL	Ai	
Standby/Write Inhibit	Vін	X ⁽¹⁾	Х	Х	High Z
Write Inhibit	Х	Х	Vін		
Write Inhibit	Х	VIL	Х		
Output Disable	Х	VIH	Х		High Z
High Voltage Chip Erase	VIL	V _H ⁽³⁾	VIL	Х	High Z
Product Identification					
Hordword	M.	\ /	\ <i>\</i>	$\begin{array}{l} A1 - A14 = V_{IL}, A9 = V_{H}, \\ A0 = V_{IL} \end{array}$	Manufacturer Code (4)
Hardware	VIL	VIL	Viн	$A1 - A14 = V_{IL}, A9 = V_H,$ $A0 = V_{IH}$	Device Code ⁽⁴⁾
Software ⁽⁵⁾				$A0 = V_{IL}$	Manufacturer Code ⁽⁴⁾
Soliwale				A0 = VIH	Device Code ⁽⁴⁾

Notes: 1. X can be V_{IL} or V_{IH} .

2. Refer to AC Programming Waveforms.

3. $V_H = 12.0V \pm 0.5V$.

4. Manufacturer Code: 1F, Device Code: DC

5. See details under Software Product Identification Entry/Exit.

DC Characteristics

Symbol	Parameter Condition		Min	Мах	Units
ILI	Input Load Current	$V_{IN} = 0V$ to V_{CC}		10	μA
ILO	Output Leakage Current	$V_{I/O} = 0V$ to V_{CC}		10	μA
ISB1	V _{CC} Standby Current CMOS	$\overline{CE} = V_{CC} - 0.3V$ to V _{CC}		300	μA
I _{SB2}	V _{CC} Standby Current TTL	$\overline{CE} = 2.0V$ to V _{CC}		3	mA
Icc	V _{CC} Active Current	f= 5 MHz; I _{OUT} = 0 mA		50	mA
VIL	Input Low Voltage			0.8	V
VIH	Input High Voltage		2.0		V
Vol	Output Low Voltage	I _{OL} = 2.1 mA		.45	V
VOH1	Output High Voltage	I _{OH} = -400 μA	2.4		V
V _{OH2}	Output High Voltage CMOS	$I_{OH} = -100 \ \mu A; \ V_{CC} = 4.5 V$	4.2		V

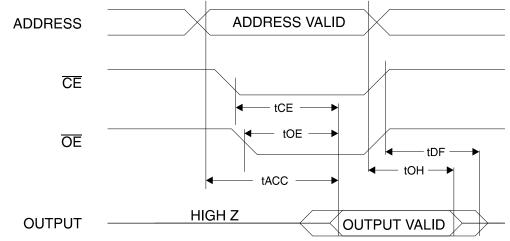
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AC Read Characteristics

		AT290	257-70	AT29C257-90		AT29C257-12 AT29C257-15				
Symbol	Parameter	Min	Max	Min	Max	Min	Max	Min	Max	Units
tACC	Address to Output Delay		70		90		120		150	ns
t _{CE} ⁽¹⁾	CE to Output Delay		70		90		120		150	ns
toe (2)	OE to Output Delay	0	40	0	40	0	50	0	70	ns
t _{DF} ^(3, 4)	CE or OE to Output Float	0	25	0	25	0	30	0	40	ns
tон	Output Hold from OE, CE or Address, whichever occurred first	0		0		0		0		ns

AC Read Waveforms (1, 2, 3, 4)



- Notes: 1. \overline{CE} may be delayed up to t_{ACC} t_{CE} after the address transition without impact on t_{ACC}.
 - OE may be delayed up to t_{CE} t_{OE} after the falling edge of CE without impact on t_{CE} or by t_{ACC} - t_{OE} after an address change without impact on t_{ACC}.
- 3. t_{DF} is specified from \overline{OE} or \overline{CE} whichever occurs first ($C_L = 5 \text{ pF}$).
- 4. This parameter is characterized and is not 100% tested.

1.8K

1.3K

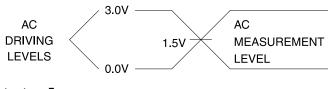
Output Test Load 5.0V

OUTPUT

PIN

100 pF

Input Test Waveforms and Measurement Level





Pin Capacitance $(f = 1 \text{ MHz}, T = 25^{\circ}\text{C})^{(1)}$

	Тур	Max	Units	Conditions
C _{IN}	4	6	pF	$V_{IN} = 0V$
Соит	8	12	pF	$V_{OUT} = 0V$

Note: 1. This parameter is characterized and is not 100% tested.



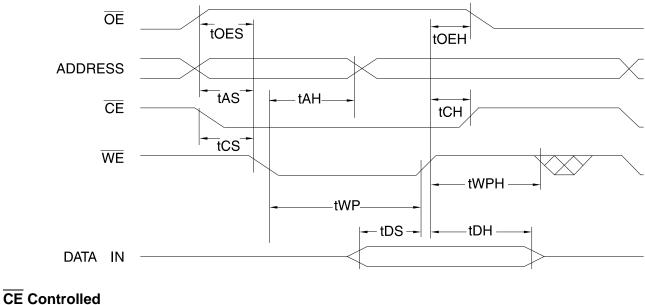


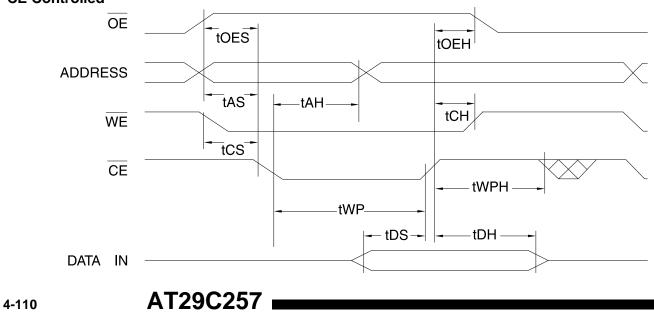
AC Byte Load Characteristics

Symbol	Parameter	Min	Max	Units
tas, toes	Address, OE Set-up Time	0		ns
tан	Address Hold Time	50		ns
tcs	Chip Select Set-up Time	0		ns
tсн	Chip Select Hold Time	0		ns
twp	Write Pulse Width (\overline{WE} or \overline{CE})	90		ns
tDS	Data Set-up Time	35		ns
tdн, toeн	Data, OE Hold Time	0		ns
twph	Write Pulse Width High	100		ns

AC Byte Load Waveforms





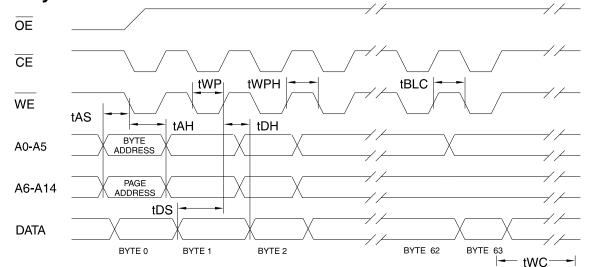




Symbol	Parameter	Min	Max	Units
twc	Write Cycle Time		10	ms
tas	Address Set-up Time	0		ns
t _{AH}	Address Hold Time	50		ns
tDS	Data Set-up Time	35		ns
tDH	Data Hold Time	0		ns
twp	Write Pulse Width	90		ns
tBLC	Byte Load Cycle Time		150	μs
twpн	Write Pulse Width High	100		ns

Program Cycle Characteristics

Program Cycle Waveforms (1, 2, 3)



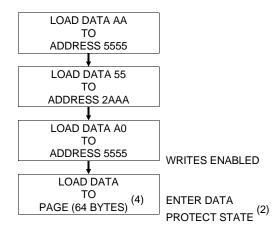
Notes: 1. A6 through A14 must specify the page address during each high to low transition of WE (or CE).
2. OE must be high when WE and CE are both low.

3. All bytes that are not loaded within the page being programmed will be indeterminate.





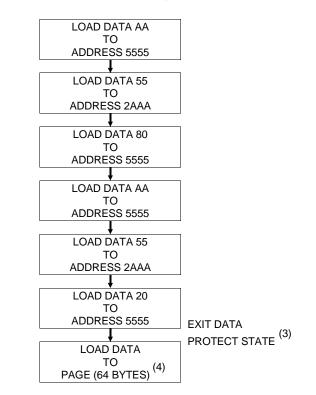
Software Data Protection Enable Algorithm ⁽¹⁾



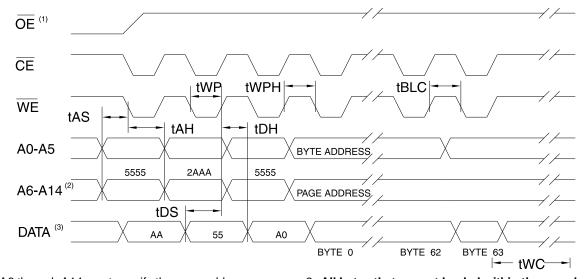
Notes for software program code:

- 1. Data Format: I/O7 I/O0 (Hex); Address Format: A14 - A0 (Hex).
- 2. Data Protect state will be activated at end of program cycle.
- 3. Data Protect state will be deactivated at end of program period.
- 4. 64-bytes of data **must be** loaded.

Software Data Protection Disable Algorithm ⁽¹⁾



Software Protected Program Cycle Waveform ^(1, 2, 3)



- Notes: 1. A6 through A14 must specify the page address during each high to low transition of WE (or CE) <u>after</u> the software code <u>has</u> been <u>entered</u>.
- 3. All bytes that are not loaded within the page being programmed will be indeterminate.
- 2. \overline{OE} must be high when \overline{WE} and \overline{CE} are both low.

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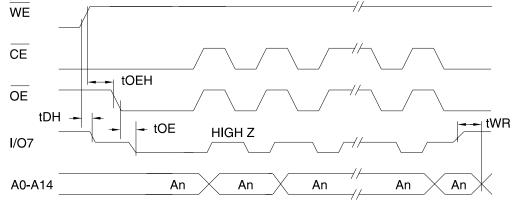
Data Polling Characteristics ⁽¹⁾

Symbol	Parameter	Min	Тур	Max	Units
tDH	Data Hold Time	0			ns
tоен	OE Hold Time	10			ns
tOE	OE to Output Delay ⁽²⁾				ns
twR	Write Recovery Time	0			ns

Notes: 1. These parameters are characterized and not 100% tested.

2. See toE spec in AC Read Characteristics.

Data Polling Waveforms

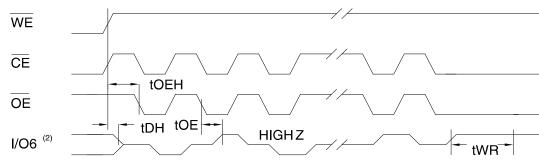


Toggle Bit Characteristics ⁽¹⁾

Symbol	Parameter	Min	Тур	Max	Units
tDH	Data Hold Time	0			ns
tоен	OE Hold Time	10			ns
tOE	OE to Output Delay ⁽²⁾				ns
tOEHP	OE High Pulse	150			ns
t _{WR}	Write Recovery Time	0			ns

Notes: 1. These parameters are characterized and not 100% tested. 2. See t_{OE} spec in AC Read Characteristics.

Toggle Bit Waveforms^(1, 2, 3)

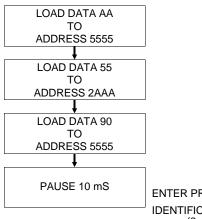


- Notes: 1. Toggling either \overline{OE} or \overline{CE} or both \overline{OE} and \overline{CE} will operate toggle bit.
 - 2. Beginning and ending state of I/O6 will vary.
- 3. Any address location may be used but the address should not vary.





Software Product Identification Entry (1)

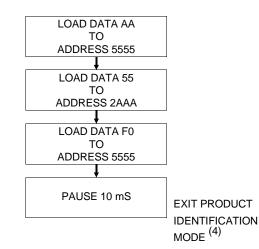


ENTER PRODUCT IDENTIFICATION MODE (2, 3, 5)

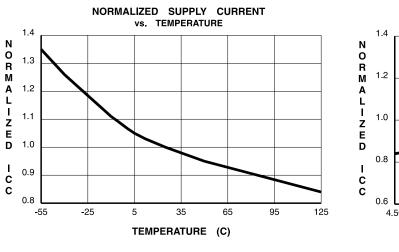
Notes for software product identification:

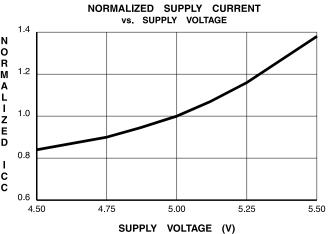
- 1. Data Format: I/O7 I/O0 (Hex); Address Format: A14 - A0 (Hex).
- 2. A1 A14 = V_{IL} . Manufacture Code is read for A0 = V_{IL} ; Device Code is read for A0 = V_{IH} .
- 3. The device does not remain in identification mode if powered down.
- 4. The device returns to standard operation mode.
- 5. Manufacturer Code: 1F Device Code: DC

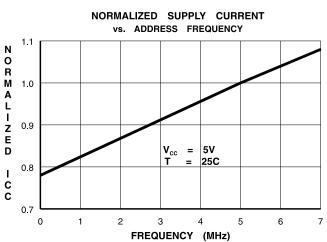
Software Product (1) Identification Exit



AT29C257











Ordering Information

tACC	lcc	(mA)	Ordering Code	Deekene	
(ns)	Active	Standby	Ordering Code	Package	Operation Range
70	50	0.3	AT29C257-70JC	32J	Commercial (0° to 70°C)
	50	0.3	AT29C257-70JI	32J	Industrial (-40° to 85°C)
90	50	0.3	AT29C257-90JC	32J	Commercial (0° to 70°C)
	50	0.3	AT29C257-90JI	32J	Industrial (-40° to 85°C)
120	50	0.3	AT29C257-12JC	32J	Commercial (0° to 70°C)
	50	0.3	AT29C257-12JI	32J	Industrial (-40° to 85°C)
150	50	0.3	AT29C257-15JC	32J	Commercial (0° to 70°C)
	50	0.3	AT29C257-15JI	32J	Industrial (-40° to 85°C)

Package Type	
32J	32 Lead, Plastic J-Leaded Chip Carrier (PLCC)